

HW#2 SOLUTION

D) prob. 2.16

a) as $T \rightarrow 0$, $n \rightarrow 0$ and $p \rightarrow 0$

b) Since $N \gg n_i$, one would have

$$n = N_D \text{ and } p = n_i^2 / N_D \quad \dots \text{ if a donor.}$$

$$p = N_A \text{ and } n = n_i^2 / N_A \quad \dots \text{ if an acceptor.}$$

$$\text{we are told } n = N \text{ and } p = n_i^2 / N$$

∴ impurity is a donor.

c) Here we are given the minority carrier concentration, $n = 10^5 / \text{cm}^3$. As long as the Si is nondegenerate, we can write

$$np = n_i^2$$

$$\text{thus } p = n_i^2 / n = (10^{10})^2 / 10^5 = 10^{15} \text{ cm}^{-3}$$

d) Given $E_F - E_i = 0.259 \text{ eV}$ and $T = 300 \text{ K}$,

$$n = n_i e^{(E_F - E_i) / kT} = (10^{10}) e^{0.259 / 0.0259} = 2.20 \times 10^{14} \text{ cm}^{-3}$$

$$p = n_i e^{(E_i - E_F) / kT} = (10^{10}) e^{-0.259 / 0.0259} = 4.54 \times 10^5 \text{ cm}^{-3}$$

e) Employing the np product relationship,

$$np = n^2 / 2 = n_i^2$$

$$n = \sqrt{2} n_i = 1.414 \times 10^{13} \text{ cm}^{-3}$$

Next, employing the charge neutrality relationship,

$$p - n + N_D - N_A = n / 2 - n + N_D = 0$$

$$N_D = n / 2 = n_i / \sqrt{2} = 0.707 \times 10^{13} \text{ cm}^{-3}$$

2)

a) $N_d - N_a = 3 \times 10^{15} \text{ cm}^{-3} \Rightarrow n_i$.

$\therefore n = 3 \times 10^{15} \text{ cm}^{-3}$

from $n_i^2 = n \cdot p$.

$p = \frac{n_i^2}{n} = \frac{(1.1 \times 10^{10})^2}{3 \times 10^{15}} = 4.03 \times 10^4 \text{ cm}^{-3}$

b) $n_i = 1.1 \times 10^{10} = \sqrt{N_c N_v} e^{-E_g/2kT}$

from $E_g \Rightarrow 2E_g$.

$n_{i, \text{new}} = \sqrt{N_c N_v} e^{-2E_g/2kT} = \sqrt{N_c N_v} e^{-E_g/kT} \cdot e^{-E_g/2kT} = 1.1 \times 10^{10} \times e^{-\frac{1.1}{2 \times 0.026}}$
 $= 0.336 \text{ cm}^{-3}$

$\therefore \text{new } n_i = 0.336 \text{ cm}^{-3}$

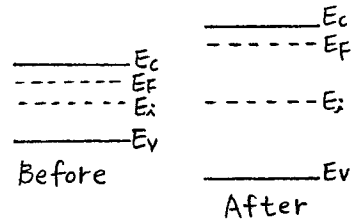
$\therefore p = \frac{n_i^2}{n} = \frac{(0.336)^2}{3 \times 10^{15}} = 3.76 \times 10^{-17} \text{ cm}^{-3}$: almost nothing.

from eq. $n = N_c e^{(E_F - E_c)/kT}$, all variables are constant.

$\therefore E_F$ don't move with respect to E_c

from eq. $n = n_i e^{(E_F - E_i)/kT}$, n_i is changed.

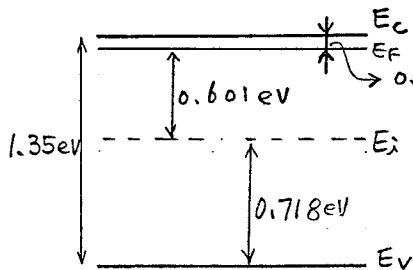
$\therefore E_F$ move with respect to E_i .



3) $(N_d - N_a = 1 \times 10^{17} \Rightarrow n_i$
 $E_g = 1.35 \text{ eV}$.

$E_i = \frac{E_c + E_v}{2} + \frac{3}{4} kT \ln\left(\frac{m_p^*}{m_n^*}\right) = \frac{1.35}{2} + \frac{3}{4} \times 0.026 \times \ln\left(\frac{0.54}{0.06}\right)$
 $= 0.718 \text{ eV}$

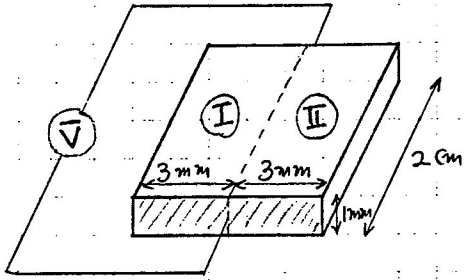
$E_F - E_i = kT \ln\left(\frac{N_d - N_a}{n_i}\right) = 0.026 \times \ln\left(\frac{1 \times 10^{17}}{9 \times 10^6}\right) = 0.601 \text{ eV}$



$3kT = 0.078 \text{ eV}$: degenerate region

0.031 eV : this means E_F is in degenerate region.

4)



- Ⓘ $N_a = 7 \times 10^{16} \text{ cm}^{-3}$: Boron
 $N_d = 6 \times 10^{16} \text{ cm}^{-3}$: Arsenic
- Ⓣ $N_d = 1 \times 10^{17} \text{ cm}^{-3}$: Arsenic
 $N_a = 3 \times 10^{16} \text{ cm}^{-3}$: Boron

for Ⓘ $N_a - N_d = 1 \times 10^{16} \gg n_i$: p-type Si.

for Ⓣ $N_d - N_a = 7 \times 10^{16} \gg n_i$: n-type Si

$$R_s = \frac{1}{\frac{1}{R_{\text{I}}} + \frac{1}{R_{\text{II}}}}$$

$$R_{\text{I}} = \frac{\rho l}{A} = \frac{l}{\sigma A} = \frac{l}{q \mu_p P A} = \frac{2}{1.6 \times 10^{-19} \times 300 \times 1 \times 10^{16} \times 0.1 \times 0.3}$$

$$= 138.89 (\Omega)$$

NOTE: mobilities taken using $N_A + N_D = 1.3 \times 10^{17}$ (happens to be the same in both I and II) and estimated from table

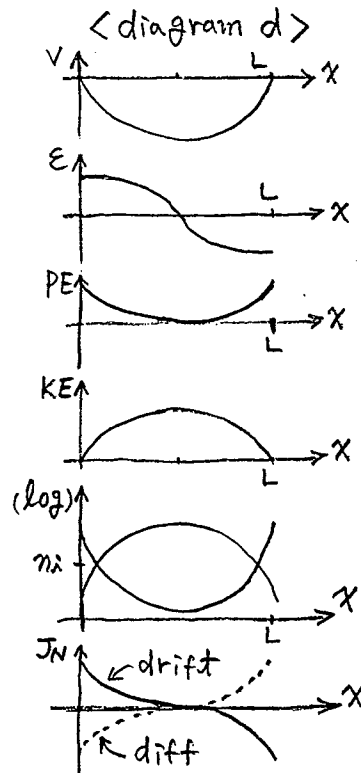
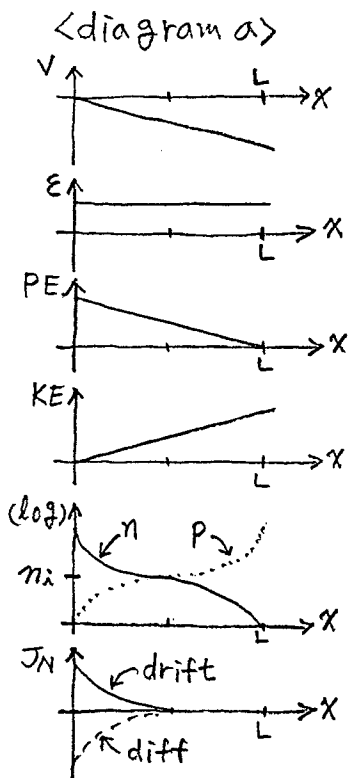
$$R_{\text{II}} = \frac{l}{q \mu_n n A} = \frac{2}{1.6 \times 10^{-19} \times 700 \times 7 \times 10^{16} \times 0.1 \times 0.3}$$

$$= 8.50 (\Omega)$$

$$\therefore R_s = \frac{138.89 \times 8.50}{138.89 + 8.50} = 8.01 (\Omega)$$

5)

- a) Yes for all cases. The semiconductor is concluded to be in equilibrium because the Fermi level has the same energy value (it is constant) as a function of position.
- b) V vs. x has the same functional form as the "upside down" of E_c (or E_i or E_v). The sketches that follow were constructed taking the arbitrary reference voltage to be $V=0$ at $x=0$.
- c) E vs. x is determined by noting the slope of the energy bands as a function of position.
- d) For electrons: $PE = E_c - E_F$ and $KE = E - E_c$
 For holes: $PE = E_F - E_v$ and $KE = E_v - E$.
- e) The general carrier concentration variation can be deduced by noting $E_F - E_i$ vs. x . Under equilibrium conditions, $n = n_i \exp[(E_F - E_i)/kT]$ and $p = n_i \exp[(E_i - E_F)/kT]$ if it is nondegenerate.
- f) Since $J_{N,drift} = q\mu_n n E$, the general variation of $J_{N,drift}$ can be deduced by conceptually forming the product of the E vs. x dependence sketched in part c) and the n vs. x dependence sketched in part e). Under equilibrium conditions, $J_N = J_{N,drift} + J_{N,diff} = 0$. thus $J_{N,diff} = -J_{N,drift}$.



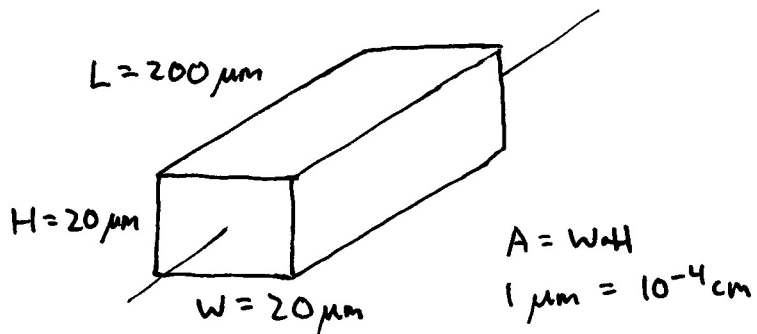
(final exam spring 2007 problem 2)

6.

intrinsic silicon $T = 300\text{K}$

a) resistance $R = \frac{\rho L}{A}$

resistivity $\rho = \frac{1}{q(\mu_n n + \mu_p p)}$



$n = p = n_i = 1.1 \times 10^{10}\ \text{cm}^{-3}$ $\mu_n \approx 1358\ \text{cm}^2/\text{V}\cdot\text{sec}$ $\mu_p \approx 461\ \text{cm}^2/\text{V}\cdot\text{sec}$

$$\rho = \frac{1}{1.6 \times 10^{-19} (1358 \cdot 1.1 \times 10^{10} + 461 \cdot 1.1 \times 10^{10})} = 3.124 \times 10^5\ \Omega\text{cm}$$

$$R = \frac{(3.124 \times 10^5) \cdot 0.02\ \text{cm}}{0.002 \cdot 0.002\ \text{cm}^2} = 1.56 \times 10^9\ \Omega = 1.56\ \text{G}\Omega$$

b) The fastest-changing, and therefore determining, parameter under changing temperatures is the intrinsic carrier concentration n_i , which increases with temperature (more thermal energy enables increased carrier generation).

Resistivity is inversely proportional to n_i ($\bar{n} = p$ in intrinsic Si), so it will decrease with increasing temperature. Resistance will do the same.

Heating a metal resistor usually increases its resistance;

metals are already flush with carriers, which experience resistance by scattering off ions, so higher temperatures only impede their progress more.

c)

$$\rho = \frac{1}{q(\mu_n + \mu_p) n_i}$$

$$n_i \approx \sqrt{N_c N_v} e^{-E_g/2kT}$$

Now μ_n, μ_p, N_c, N_v all depend on temperature, but they have a much weaker dependence than $e^{-E_g/2kT}$

\therefore Ignore these lesser factors

$$\rho \propto e^{E_g/2kT}$$

$$\frac{d\rho}{dT} \propto e^{E_g/2kT} \frac{E_g}{2k} (-T^{-2})$$

$$\frac{d\rho}{dT} = \rho \frac{-E_g}{2kT^2}$$

$$\frac{d\rho}{dT} \frac{1}{\rho} = \frac{-E_g}{2kT^2} = \frac{-1.1 \text{ eV}}{2(0.026 \text{ eV})(300 \text{ K})}$$

$$\boxed{\frac{\left(\frac{d\rho}{dT}\right)}{\rho} = .07/\text{K} = 7\%/K}$$